Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/734,198	LIN ET AL.
Examiner	Art Unit
Adeel Haroon	2618

Examiner
AH

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NO (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
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